

MOSFET

OptiMOS[™]5 Power-Transistor, 80 V

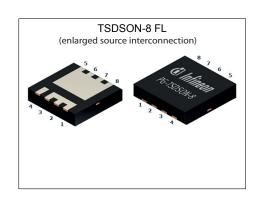
Features

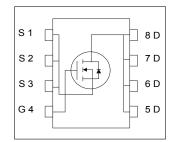
- Ideal for high frequency switching and sync. rec.
 Optimized technology for DC/DC converters
 Excellent gate charge x R_{DS(on)} product (FOM)
 Very low on-resistance R_{DS(on)}
- N-channel, logic level

- 100% avalanche tested
 Pb-free plating; RoHS compliant
 Qualified according to JEDEC¹⁾ for target applications
 Halogen-free according to IEC61249-2-21
- Higher solder joint reliability with enlarged source interconnection

Table 1 **Kev Performance Parameters**

Parameter	Value	Unit
V _{DS}	80	V
R _{DS(on),max}	7.0	mΩ
I_{D}	40	A
Qoss	29	nC
Q _G (0V4.5V)	14	nC











Type / Ordering Code	Package	Marking	Related Links
BSZ070N08LS5	PG-TSDSON-8 FL	070N08L	-



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1 Maximum ratings at T_A =25 °C, unless otherwise specified

Table 2 Maximum ratings

Parameter	0		Value	s	11	Note / Took Oom did on
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current	I _D	- - -	-	40 40 13	А	T _C =25 °C T _C =100 °C T _A =25 °C, R _{thJA} =60 K/W ¹⁾
Pulsed drain current ²⁾	I _{D,pulse}	-	-	160	Α	T _C =25 °C
Avalanche energy, single pulse ³⁾	E _{AS}	-	-	104	mJ	$I_{\rm D}$ =20 A, $R_{\rm GS}$ =25 Ω
Gate source voltage	V _{GS}	-20	-	20	V	-
Power dissipation	P _{tot}	-	-	69	W	T _C =25 °C
Operating and storage temperature	T _j , T _{stg}	-55	-	150	°C	IEC climatic category; DIN IEC 68-1: 55/150/56

2 Thermal characteristics

Table 3 **Thermal characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Тур.	Max.	Ullit	Note / Test Condition
Thermal resistance, junction - case, bottom	R _{thJC}	-	1.1	1.8	K/W	-
Device on PCB, minimal footprint	R _{thJA}	-	-	62	K/W	-
Device on PCB, 6 cm ² cooling area ¹⁾	R _{thJA}	-	-	60	K/W	-

 $^{^{1)}}$ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air. $^{2)}$ See Diagram 3 for more detailed information $^{3)}$ See Diagram 13 for more detailed information



3 Electrical characteristics

Table 4 Static characteristics

Parameter	0		Values			
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V _{(BR)DSS}	80	-	-	V	V _{GS} =0 V, I _D =1 mA
Gate threshold voltage	V _{GS(th)}	1.1	1.7	2.3	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=36\ \mu {\rm A}$
Zero gate voltage drain current	I _{DSS}	-	0.1 10	1 100	μA	V _{DS} =80 V, V _{GS} =0 V, T _j =25 °C V _{DS} =80 V, V _{GS} =0 V, T _j =125 °C
Gate-source leakage current	I _{GSS}	-	1	100	nA	V _{GS} =20 V, V _{DS} =0 V
Drain-source on-state resistance	R _{DS(on)}	-	7.4 5.9	9.4 7.0	mΩ	V _{GS} =4.5 V, I _D =10 A V _{GS} =10 V, I _D =20 A
Gate resistance ¹⁾	R _G	-	1.3	2	Ω	-
Transconductance	g _{fs}	26	52	-	S	$ V_{DS} > 2 I_D R_{DS(on)max}, I_D = 20 A$

Table 5 Dynamic characteristics

Parameter	C: mala al	Values			11	
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance ¹⁾	C _{iss}	-	1800	2340	pF	V _{GS} =0 V, V _{DS} =40 V, f=1 MHz
Output capacitance ¹⁾	Coss	-	280	364	pF	V _{GS} =0 V, V _{DS} =40 V, f=1 MHz
Reverse transfer capacitance ¹⁾	C _{rss}	-	12	21	pF	V _{GS} =0 V, V _{DS} =40 V, <i>f</i> =1 MHz
Turn-on delay time	$t_{\sf d(on)}$	-	6.1	-	ns	V_{DD} =40 V, V_{GS} =10 V, I_{D} =20 A, $R_{G,ext}$ =3 Ω
Rise time	t _r	-	4.8	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =20 A, $R_{\rm G,ext}$ =3 Ω
Turn-off delay time	$t_{ m d(off)}$	-	24.6	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =20 A, $R_{\rm G,ext}$ =3 Ω
Fall time	t _f	-	5.8	-	ns	V_{DD} =40 V, V_{GS} =10 V, I_{D} =20 A, $R_{G,ext}$ =3 Ω

Table 6 Gate charge characteristics²⁾

Parameter	Symbol	Values			Unit	Note / Test Condition
	Symbol	Min.	Тур.	Max.	Ullit	Note / Test Condition
Gate to source charge	Q _{gs}	-	5	-	nC	V _{DD} =40 V, I _D =20 A, V _{GS} =0 to 4.5 V
Gate to drain charge ¹⁾	Q_{gd}	-	5	7	nC	V _{DD} =40 V, I _D =20 A, V _{GS} =0 to 4.5 V
Switching charge	Q _{sw}	-	6.9	-	nC	V _{DD} =40 V, I _D =20 A, V _{GS} =0 to 4.5 V
Gate charge total ¹⁾	Qg	-	14.1	18	nC	V _{DD} =40 V, I _D =20 A, V _{GS} =0 to 4.5 V
Gate plateau voltage	V _{plateau}	-	2.9	-	V	V _{DD} =40 V, I _D =20 A, V _{GS} =0 to 4.5 V
Gate charge total, sync. FET	Q _{g(sync)}	-	25	-	nC	V _{DS} =0.1 V, V _{GS} =0 to 10 V
Output charge ¹⁾	Qoss	-	29	39	nC	V _{DD} =40 V, V _{GS} =0 V

 $^{^{1)}}$ Defined by design. Not subject to production test $^{2)}$ See "Gate charge waveforms" for parameter definition

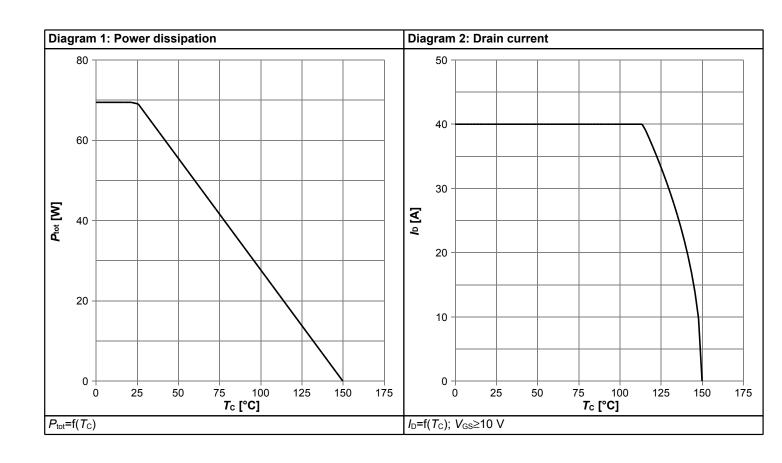


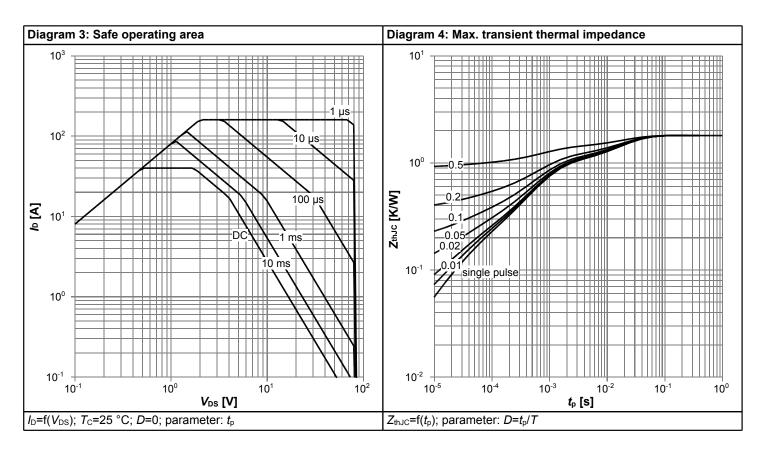
Table 7 Reverse diode

Parameter	Symbol		Values			Note / Took Condition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode continous forward current	Is	-	-	40	Α	<i>T</i> _C =25 °C
Diode pulse current	I _{S,pulse}	-	-	160	Α	<i>T</i> _C =25 °C
Diode forward voltage	V _{SD}	-	0.85	1.2	V	V _{GS} =0 V, I _F =20 A, T _j =25 °C
Reverse recovery time ¹⁾	<i>t</i> _{rr}	-	32	64	ns	V _R =40 V, I _F =20 A, di _F /dt=100 A/μs
Reverse recovery charge ¹⁾	Qrr	-	27	54	nC	V_R =40 V, I_F =20 A, di_F/dt =100 A/ μ s

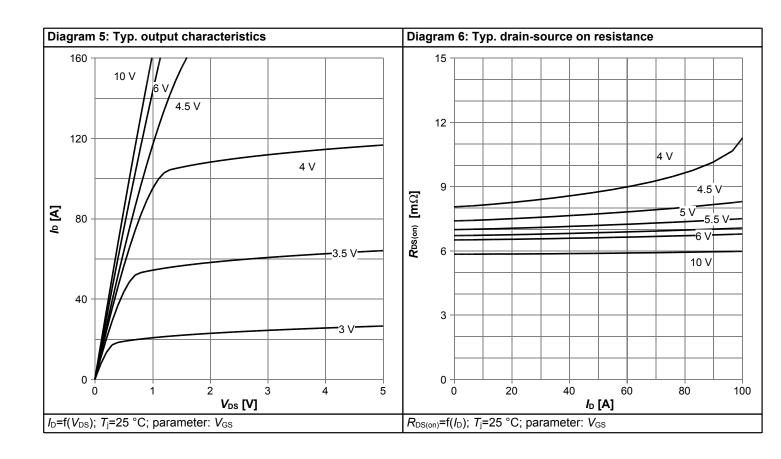


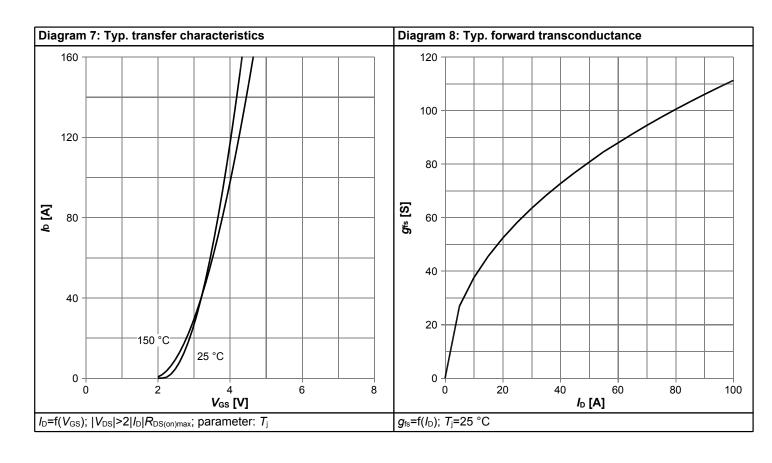
4 Electrical characteristics diagrams



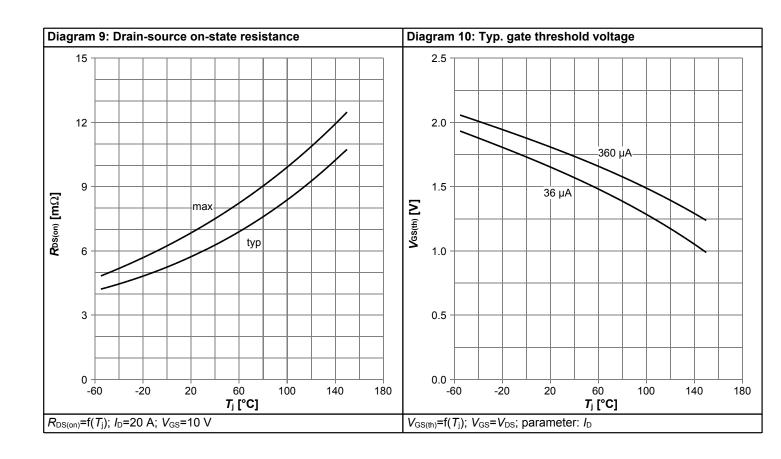


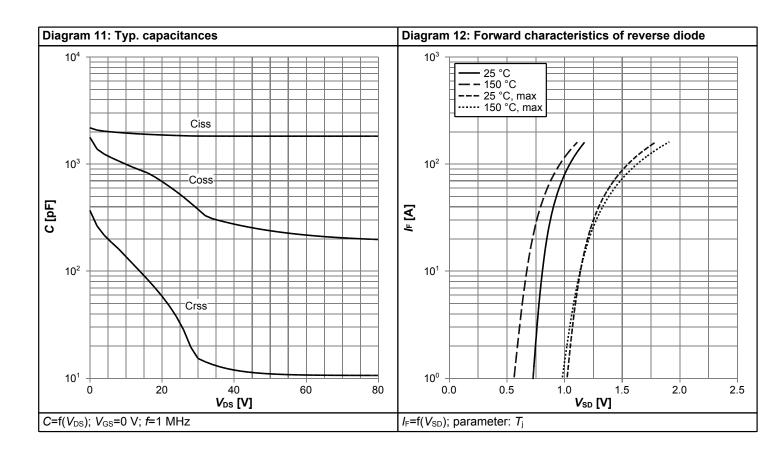




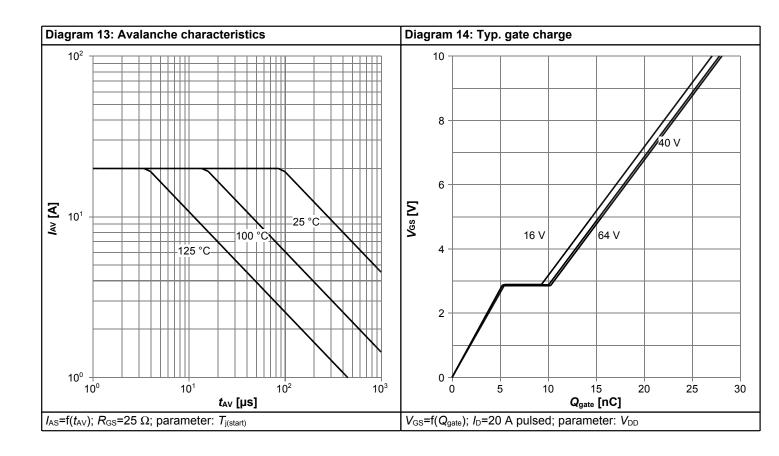


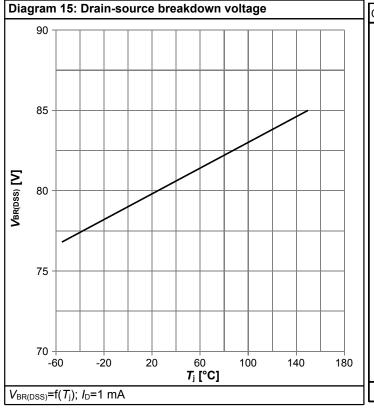


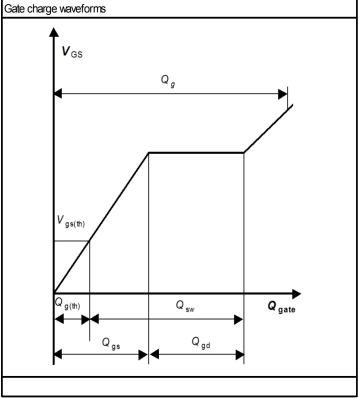














5 Package Outlines

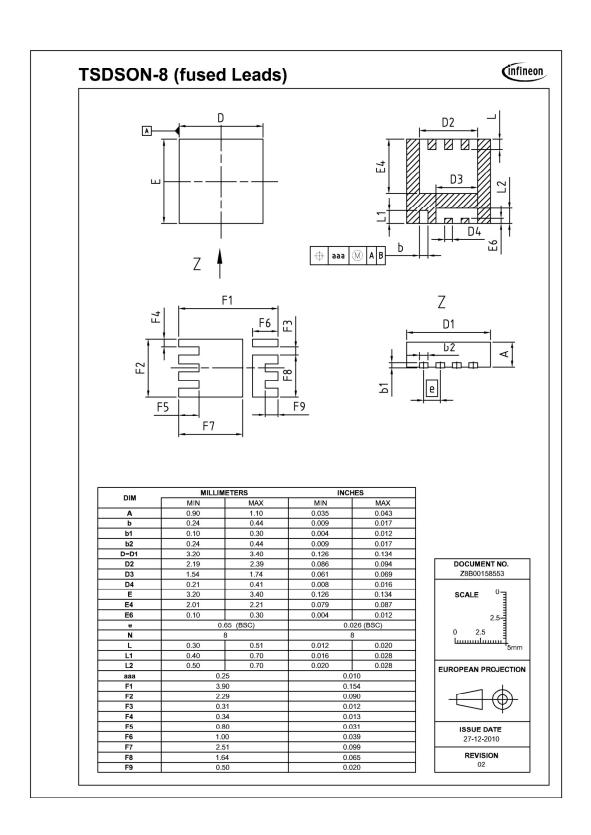


Figure 1 Outline PG-TSDSON-8 FL, dimensions in mm/inches



Revision History

BSZ070N08LS5

Revision: 2016-08-18, Rev. 2.2

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.0	2016-03-23	Release of final version
2.1	2016-04-21	Update "Gate threshold voltage"
2.2	2016-08-18	Update Qsw

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